

Search Notes

Application/Control No.

10/820,245

Examiner

Pho M. Luu

Applicant(s)/Patent under
Reexamination

BYEON ET AL.

Art Unit

2824

SEARCHED

Class	Subclass	Date	Examiner
365	195	8/1/2005	PL
365	189.07	8/1/2005	PL
365	189.05	8/1/2005	PL
365	189.12	8/1/2005	PL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
365	195	8/1/2005	PL
365	189.05	8/1/2005	PL
365	189.07	8/1/2005	PL
365	189.12	8/1/2005	PL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM-TDB) See Search Printout	8/1/2005	PL
Consulted With Primary VanThu Nguyen	8/1/2005	PL
Interference Search See Printout	8/1/2005	PL
365/195 (text search only) see Printout	8/1/2005	PL